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| Search Notes  | Application/Control No. 10811071 | Applicant(s)/Patent Under Reexamination FENNEY ET AL. |
| | Examiner Hajnik, Daniel F | Art Unit 2628 |

| SEARCHED | | | |
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| Class | Subclass | Date | Examiner |
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| SEARCH NOTES | | |
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| Search Notes | Date | Examiner |
| Update Search conducted in EAST | 10/12/08 | DFH |
| EAST text search (US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB -- see search history printout) | 10/12/08 | DFH |
| Update search conducted in EAST | 7/29/09 | DFH |
| NPL search conducted in ACM, IEEE, and Google, search terms include sample, micropolygon, and primitive | 7/30/09 | DFH |
| EAST search history attached | 8/1/09 | DFH |
| Updated Inventor name search performed and prior art search updated in EAST; NPL update search conducted | 6/27/10 | DFH |
| EAST search history attached | 6/30/10 | DFH |

| INTERFERENCE SEARCH | | | |
|---------------------|--|---------|----------|
| Class | Subclass | Date | Examiner |
| | See Interference search history printout | 6/30/10 | DFH |

/DANIEL F HAJNIK/
Examiner, Art Unit 2628